TO SIN THE INITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Hae-seok PARK et al.

Art Unit:

2862

Serial No. 10/763,394

Examiner:

David M. Schindler

Filed: January 26, 2004

Confirmation No. 4583

For: FLUXGATE SENSOR INTEGRATED IN A SEMICONDUCTOR SUBSTRATE AND

SEMICONDUCTOR SUBSTRATE AND METHOD FOR MANUFACTURING THE

SAME

Attorney Docket No. 277/044

AMENDMENT UNDER 37 C.F.R. § 1.116

Mail Stop: BOX AF Commissioner for Patents United States Patent and Trademark Office P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

INTRODUCTORY COMMENTS

In response to the Office Action Made Final dated June 7, 2006, the following amendments and remarks are respectfully submitted in connection with the above-identified application:

Amendments to the Claims are reflected in a listing of claims, which begins on page 2 of this paper.

Remarks begin on page 12 of this paper.